

N-Channel Super Junction Power MOSFET $\, \mathrm{I\!V}$

General Description

The series of devices use advanced trench gate super junction technology and design to provide excellent R_{DS(ON)} with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

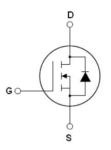
Features

- New technology for high voltage device
- Low on-resistance and low conduction losses
- Small package
- ●Ultra Low Gate Charge cause lower driving requirements
- ●100% Avalanche Tested
- ROHS compliant

Application

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)

V _{DS min@Tjmax}	550	V
R _{DS(ON)TYP} .	460	mΩ
I_D	7.2	Α
Qg	10	nC



Schematic diagram

♦ Intrinsic fast-recovery body diode

Package Marking And Ordering Information

Device	Device Package	Marking
NCE50NF520D	TO-263-2L	NCE50NF520D



TO-263-2L

V1.0

Table 1. Absolute Maximum Ratings (T_c=25℃)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (Vcs=0V)	V _{DS}	500	V
Gate-Source Voltage (V _{DS=0} V) ,AC (f>1 Hz)	Vgs	±30	V
Gate-Source Voltage (V _{DS} =0V) ,DC	Vgs	±20	V
Continuous Drain Current at Tc=25°C	I _{D (DC)}	7.2	Α
Continuous Drain Current at Tc=100°C	I _{D (DC)}	5.04	Α
Pulsed drain current (Note 1)	I _{DM (pluse)}	21.6	Α
Maximum Power Dissipation(Tc=25°C)	P _D	73	W
Derate above 25°C		0.48	W/°C
Single pulse avalanche current (Note 2)	I _{AS}	2.5	Α
Reverse diode dv/dt, $V_{DS} \leq 480 \text{ V,I}_{SD} < I_{D}$	dv/dt	15	V/ns
Drain Source voltage slope,V _{DS} ≤480 V	dv/dt	50	V/ns
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55+175	°C

V1.0



Table 2. Thermal Characteristic

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R _{thJC}	2.05	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R _{thJA}	62	°C /W

Table 3. Electrical Characteristics (TA=25℃unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states			•			
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250uA	500			V
Zero Gate Voltage Drain Current(Tc=25°ℂ)	I _{DSS}	V _{DS} =500V,V _{GS} =0V			10	μA
Zero Gate Voltage Drain Current(Tc=125℃)	I _{DSS}	V _{DS} =500V,V _{GS} =0V			300	μA
Gate-Body Leakage Current	I _{GSS}	$V_{GS}=\pm20V, V_{DS}=0V$			±200	nA
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS},I_{D}=250uA$	3		5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =3.5A		460	520	mΩ
Dynamic Characteristics						
Gate Resistance	Rg	F=1MHZ, D-S short		55		Ω
Input Capacitance	C _{iss}	., 50,414 014		354		pF
Output Capacitance	Coss	V_{DS} =50V, V_{GS} =0V,		20		pF
Reverse Transfer Capacitance	C _{rss}	F=1MHz		4.7		pF
Total Gate Charge	Qg			10		nC
Gate-Source Charge	Q _{gs}	V_{DS} =380 V , I_{D} =3.5 A ,		4.5		nC
Gate-Drain Charge	Q _{gd}	V _{GS} =10V		2.6		nC
Gate plateau voltage	Vgp			7.2		V
Switching times				•		
Turn-on Delay Time	t _{d(on)}			8		nS
Turn-on Rise Time	tr	V_{DD} =380 V , I_D =4 A ,		10		nS
Turn-Off Delay Time	t _{d(off)}	$R_G=4\Omega, V_{GS}=10V$		41		nS
Turn-Off Fall Time	t _f			9		nS
Source- Drain Diode Characteristics			•			
Source-drain current(Body Diode)	I _{SD}	T 0500			7.2	Α
Pulsed-Source-drain current(Body Diode)	I _{SDM}	T _C =25°C			21.6	Α
Forward on voltage	V _{SD}	Tj=25°C,I _{SD} =7.2A,V _{GS} =0V		1.0	1.2	V
Reverse Recovery Time	t _{rr}			105		nS
Reverse Recovery Charge	Q _{rr}	Tj=25°C,lF4A,		0.42		uC
Peak reverse recovery current	I _{rrm}	di/dt=100A/µs		7.5		Α

Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

2. Tj=25 $^{\circ}\text{C}$,VDD=50V,VG=10V, RG=25 Ω



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

Figure 1. Safe operating area

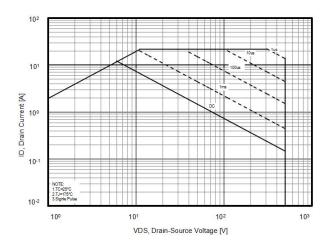


Figure 3. Output characteristics

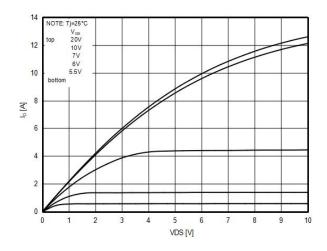


Figure 5. Static drain-source on resistance

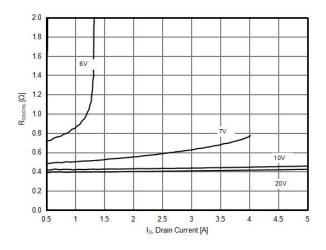


Figure 2. Source-Drain Diode Forward Voltage

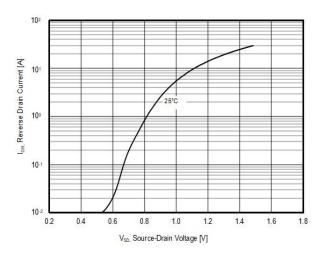


Figure 4. Transfer characteristics

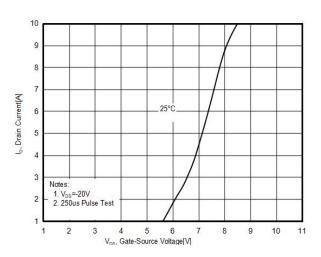


Figure 6. RDS(ON) vs Junction Temperature

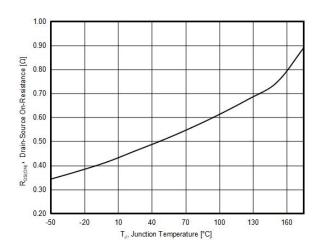




Figure 7. BV_{DSS} vs Junction Temperature

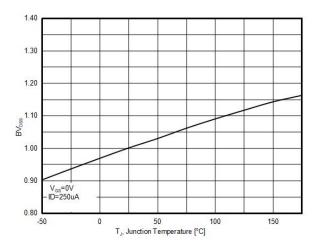


Figure 8. Maximum ID vs Junction Temperature

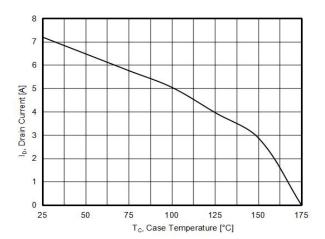


Figure 9. Gate charge waveforms

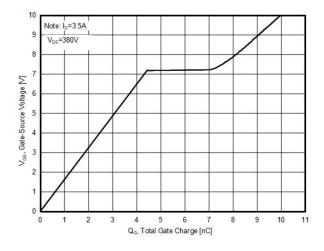
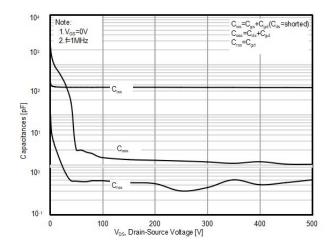


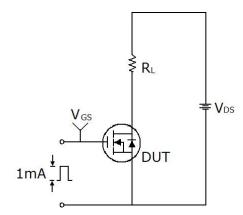
Figure 10. Capacitance

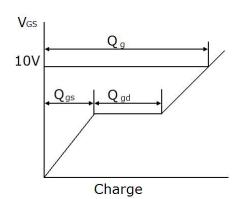




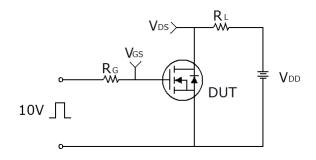
Test circuit

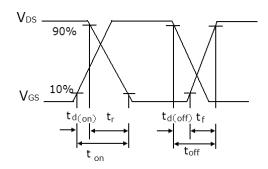
1) Gate charge test circuit & Waveform



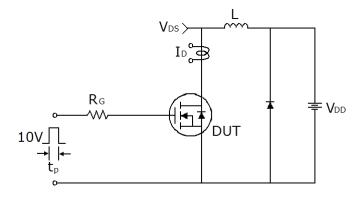


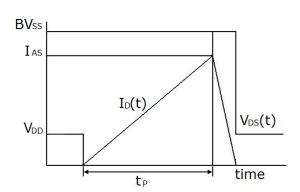
2) Switch Time Test Circuit:





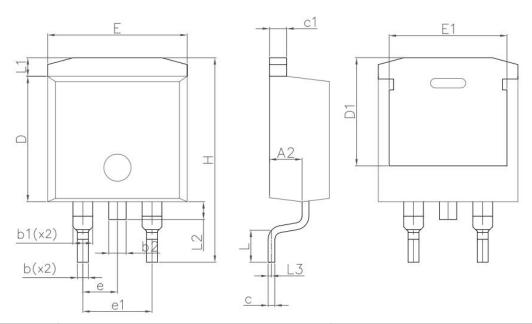
3) Unclamped Inductive Switching Test Circuit & Waveforms







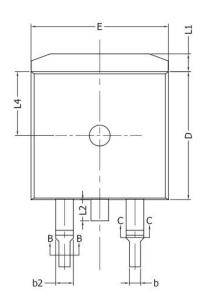
TO-263-2L-E Package Information

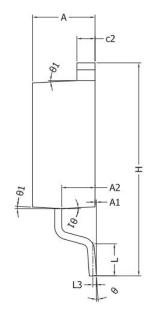


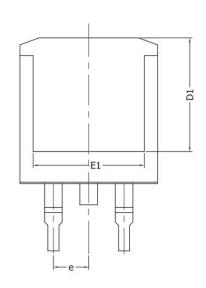
Symbol	Dimensions I	In Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
A2	4.20	4.60	0.165	0.181	
b	0.70	0.90	0.028	0.035	
b1	1.20	1.75	0.047	0.069	
b2	1.17	1.37	0.046	0.054	
С	0.40	0.60	0.016	0.024	
c1	1.15	1.40	0.045	0.055	
D	9.10	9.30	0.358	0.366	
D1	7.63	8.23	0.300	0.324	
E	10.05	10.45	0.396	0.411	
E1	8.35	8.95	0.329	0.352	
е	2.54	2.54BSC)BSC	
e1	5.08	5.08BSC)BSC	
Н	14.61	15.88	0.575	0.625	
L	1.78	2.79	0.070	0.110	
L1	1.36REF		0.054REF		
L2	1.30REF		0.051REF		



TO-263-2L-P Package Information







Symbol	Dimensions	In Millimeters	Dimensions In Inches		
Cymbol	Min.	Max.	Min.	Max.	
Α	4.40	4.60	0.173	0.181	
A1	0.00	0.25	0.000	0.010	
A2	2.20	2.60	0.087	0.102	
b	0.76	0.89	0.030	0.035	
b1	0.75	0.85	0.030	0.033	
b2	1.23	1.37	0.048	0.054	
b3	1.22	1.32	0.048	0.052	
С	0.47	0.60	0.019	0.024	
c1	0.46	0.56	0.018	0.022	
c2	1.25	1.35	0.049	0.053	
D	9.10	9.30	0.358	0.366	
D1	8.00		0.315		
E	9.80	10.00	0.386	0.394	
E1	7.80		0.307		
е	2.54	4BSC	0.100BSC		
Н	14.90	15.70	0.587	0.618	
L	2.00	2.60	0.079	0.102	
L1	1.17	1.40	0.046	0.055	
L2		1.75		0.069	
L3	0.25	0.25BSC		BSC	
L4	4.60REF		4.60REF 0.181REF		



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